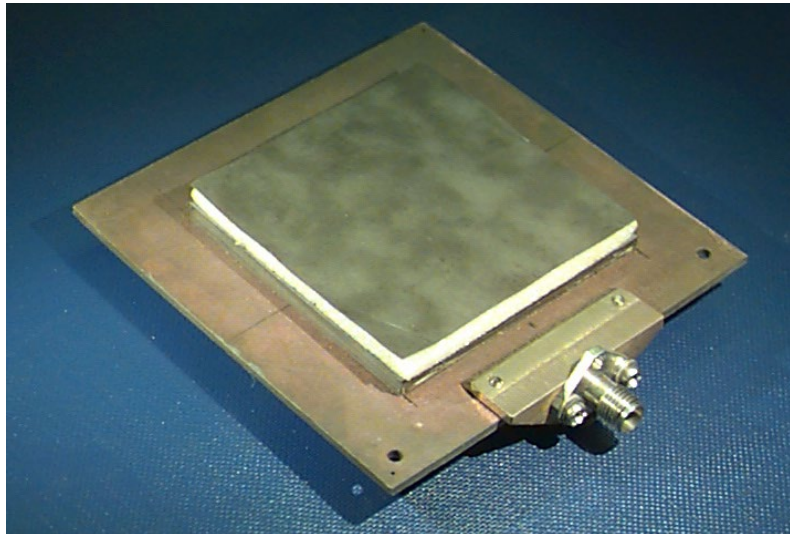


ECE 6345

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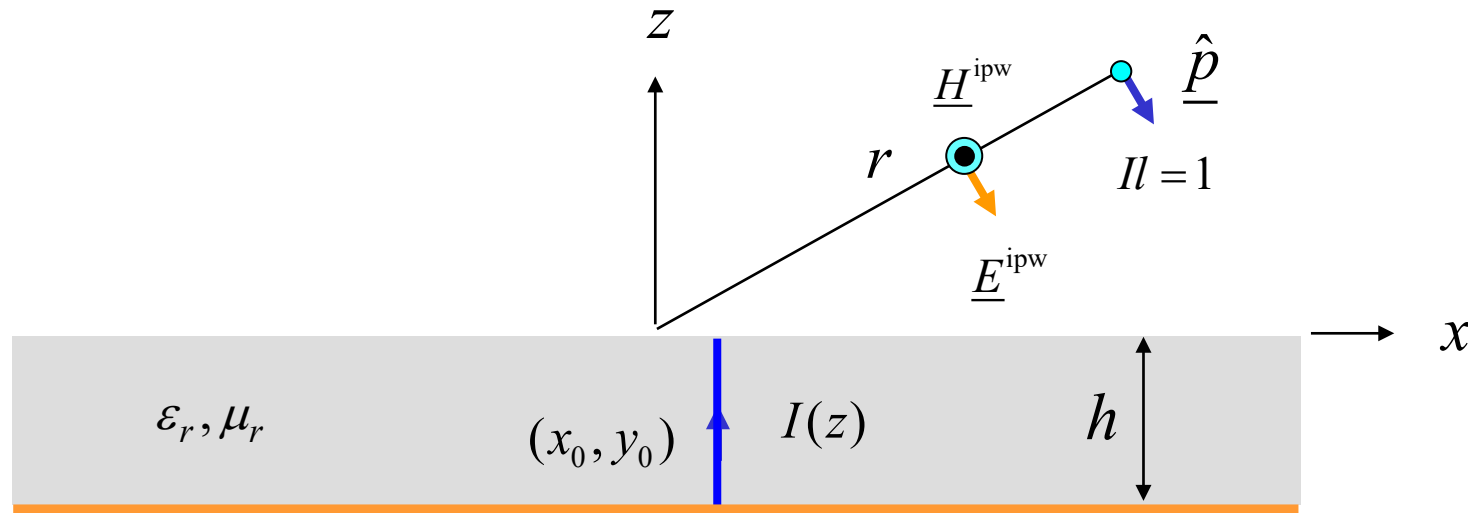
Notes 9

Overview

In this set of notes we calculate the far field of a vertical probe feed.

- We first formulate the far-field radiation from a uniform probe current of fixed (arbitrary) amplitude.
- The probe current is then related to the patch input impedance.

Radiation from Probe Current



The origin is at the center of the patch
(which has been removed).

$$E_{\phi}^{\text{FF}} = 0$$

This follows from reciprocity, since

$$\hat{\phi} \cdot \hat{z} = 0$$

$$E_{\theta}^{\text{FF}}(r, \theta, \phi) = \langle b, a \rangle = \int_{-h}^0 I(z) E_z^{\text{pw}}(z) dz$$

$$E_z^{\text{pw}}(x, y, z) = E_z^{\text{ipw}}(x, y, z) + E_z^{\text{rpw}}(x, y, z)$$

Radiation from Probe Current (cont.)

Inside the substrate we have:

$$E_z = \frac{1}{j\omega\epsilon_1} (\nabla \times \underline{H}) \cdot \hat{z} \quad \epsilon_1 = \epsilon_0\epsilon_r$$
$$= \frac{1}{j\omega\epsilon_1} \left(\frac{\partial H_y}{\partial x} - \frac{\partial H_x}{\partial y} \right)$$

Transverse variation:

$$\psi_t(x, y) = e^{j(k_x x + k_y y)}$$

Hence, we have:

$$E_z^b = \frac{1}{j\omega\epsilon_1} \left[jk_x H_y^{\text{pw}} - jk_y H_x^{\text{pw}} \right]$$

Radiation from Probe Current (cont.)

For the magnetic field inside the substrate:

$$\underline{H}^{\text{ipw}} = \underline{\hat{\phi}} \left(-\frac{E_{\theta}^{\text{ipw}}}{\eta_0} \right) = \underline{\hat{\phi}} \left(-\frac{E_0}{\eta_0} \right) e^{j(k_x x + k_y y + k_z z)}$$

From this we have:

$$H_x^{\text{ipw}} = -\frac{E_0}{\eta_0} e^{j(k_x x + k_y y + k_z z)} (-\sin \phi) \quad (\underline{\hat{\phi}} \cdot \underline{\hat{x}} = -\sin \phi)$$

$$H_y^{\text{ipw}} = -\frac{E_0}{\eta_0} e^{j(k_x x + k_y y + k_z z)} \cos \phi \quad (\underline{\hat{\phi}} \cdot \underline{\hat{y}} = \cos \phi)$$

Radiation from Probe Current (cont.)

For the total (incident plus reflected) plane-wave field we have (for the x component):

$$H_x^{\text{pw}}(x_0, y_0, 0) = H_x^{\text{ipw}}(x_0, y_0, 0)(1 - \Gamma^{\text{TM}}) = \left[\frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} \sin \phi \right] (1 - \Gamma^{\text{TM}})$$

Denote:

$$H_x^{\text{pw}}(x_0, y_0, z) = f(z) = A \cos(k_{z1}(z + h))$$

where

Setting $z = 0$ we have: $A = \frac{H_x^{\text{pw}}(x_0, y_0, 0)}{\cos(k_{z1}h)}$

$$\begin{aligned} k_{z1} &= (k_1^2 - k_x^2 - k_y^2)^{1/2} \\ &= (k_1^2 - k_0^2 \sin^2 \theta)^{1/2} \\ &= k_0 \sqrt{\mu_r \epsilon_r - \sin^2 \theta} \\ &= k_0 N_1(\theta) \end{aligned}$$

Hence, we have:

$$H_x^{\text{pw}}(x_0, y_0, z) = H_x^{\text{pw}}(x_0, y_0, 0) \left[\frac{\cos(k_{z1}(z + h))}{\cos(k_{z1}h)} \right]$$

Radiation from Probe Current (cont.)

We then have:

$$H_x^{\text{pw}}(x_0, y_0, z) = \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} \sin \phi (1 - \Gamma^{\text{TM}}) \sec(k_{z_1} h) \cos k_{z_1} (z + h)$$

Similarly,

$$H_y^{\text{pw}}(x_0, y_0, z) = \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (-\cos \phi) (1 - \Gamma^{\text{TM}}) \sec(k_{z_1} h) \cos k_{z_1} (z + h)$$

Next, use

$$E_z^{\text{pw}} = \frac{1}{\omega \epsilon_1} \left[k_x H_y^{\text{pw}} - k_y H_x^{\text{pw}} \right]$$

$$k_x = k_0 \sin \theta \cos \phi$$

$$k_y = k_0 \sin \theta \sin \phi$$

Radiation from Probe Current (cont.)

We then have:

$$E_z^{\text{pw}} = \frac{1}{\omega \varepsilon_1} \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \sec(k_{z1} h) \cos k_{z1} (z + h) \left[k_0 \sin \theta (-\cos^2 \phi - \sin^2 \phi) \right]$$

or

$$\begin{aligned} E_z^{\text{pw}} &= -\frac{1}{\omega \varepsilon_1} \frac{E_0}{\eta_0} e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \sec(k_{z1} h) \cos k_{z1} (z + h) k_0 \sin \theta \\ &= -\frac{1}{\varepsilon_r} E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \sec(k_{z1} h) \cos k_{z1} (z + h) \sin \theta \quad \left(\frac{k_0}{\omega \varepsilon_0} = \eta_0 \right) \end{aligned}$$

Radiation from Probe Current (cont.)

The far field pattern is then:

$$E_{\theta}^{\text{FF}}(r, \theta) = \frac{-1}{\epsilon_r} E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \sec(k_{z1} h) \sin \theta \int_{-h}^0 I(z) \cos(k_{z1}(z+h)) dz$$

Assume $I(z) = I_0$

$$\begin{aligned} \int_{-h}^0 I(z) \cos(k_{z1}(z+h)) dz &= I_0 \int_{-h}^0 \cos(k_{z1}(z+h)) dz \\ &= I_0 \int_0^h \cos(k_{z1}u) du \quad (u = z+h) \\ &= \frac{I_0}{k_{z1}} \sin(k_{z1}h) \\ &= I_0 h \operatorname{sinc}(k_{z1}h) \end{aligned}$$

Radiation from Probe Current (cont.)

Hence, we have:

$$E_{\theta}^{\text{FF}}(r, \theta) = \frac{-1}{\epsilon_r} E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \sec(k_{z1} h) [(I_0 h) \text{sinc}(k_{z1} h) \sin \theta]$$

or

$$E_{\theta}^{\text{FF}}(r, \theta) = (I_0 h) \left(\frac{-1}{\epsilon_r} \right) E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \text{tanc}(k_0 h N_1(\theta)) \sin \theta$$

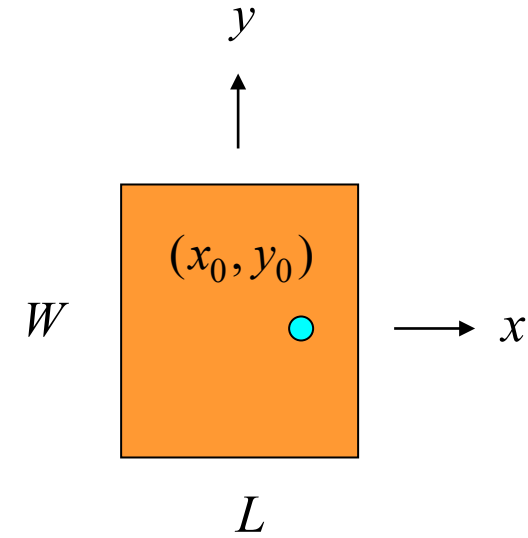
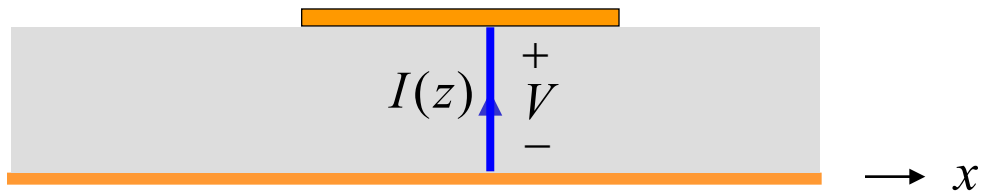
where

$$\text{tanc}(x) \equiv \frac{\tan(x)}{x} \quad (\sec(x) \text{sinc}(x) = \text{tanc}(x))$$

Calculation of Probe Current

We want to find the relation between these two.

$$J_{sx}(x, y) = A_{10}^J \cos\left(\frac{\pi x}{L}\right)$$
$$I(z) = I_0$$



$$V = Z_{\text{in}} I_0 = -h E_z(x_0, y_0)$$

Z_{in} = input impedance of dominant mode (known).

Hence, we have:

$$E_z(x_0, y_0) = -\frac{Z_{\text{in}} I_0}{h}$$

Calculation of Probe Current (cont.)

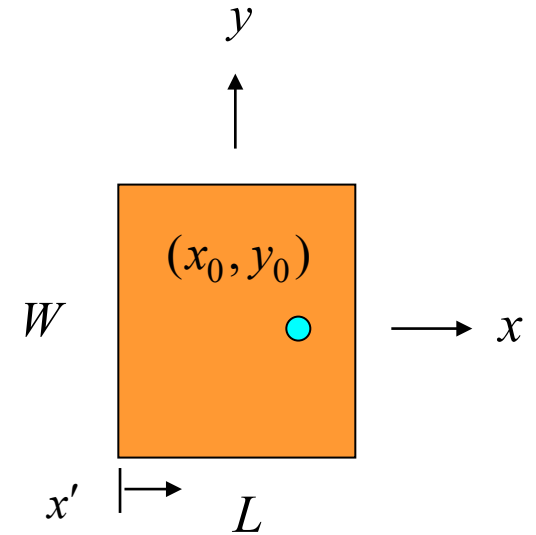
Assume: $E_z^{10}(x, y) = -A_{10}^E \sin\left(\frac{\pi x}{L}\right)$ $\left(E_z^{10}(x', y') = A_{10}^E \cos\left(\frac{\pi x'}{L}\right)\right)$

Then

$$A_{10}^E = -\frac{E_z^{10}(x_0, y_0)}{\sin\left(\frac{\pi x_0}{L}\right)} = \frac{Z_{\text{in}} I_0}{h \sin\left(\frac{\pi x_0}{L}\right)}$$

Therefore, we have:

$$E_z^{10}(x, y) = \left[\frac{-Z_{\text{in}} I_0}{h \sin\left(\frac{\pi x_0}{L}\right)} \right] \sin\left(\frac{\pi x}{L}\right)$$



Calculation of Probe Current (cont.)

From previous calculations,

$$\underline{J}_s = -\underline{\hat{z}} \times \underline{H} = \frac{1}{j\omega\mu} \nabla E_z$$

$$\begin{aligned} \underline{H} &= -\frac{1}{j\omega\mu} \nabla \times \underline{E} \\ &= -\frac{1}{j\omega\mu} \nabla \times (\underline{\hat{z}} E_z(x, y)) \\ &= -\frac{1}{j\omega\mu} (-\underline{\hat{z}} \times \nabla E_z(x, y)) \end{aligned}$$

Hence, we have:

$$J_{sx}^{10} = \frac{1}{j\omega\mu} \left(\frac{\pi}{L} \right) \left[\frac{-Z_{in} I_0}{h \sin\left(\frac{\pi x_0}{L}\right)} \right] \cos\left(\frac{\pi x}{L}\right) = A_{10}^J \cos\left(\frac{\pi x}{L}\right)$$

so that

$$A_{10}^J = -\frac{1}{j\omega\mu} \left(\frac{\pi}{L} \right) \left[\frac{Z_{in} I_0}{h \sin\left(\frac{\pi x_0}{L}\right)} \right]$$

or

$$\frac{A_{10}^J}{I_0} = -\frac{1}{j\omega\mu} \left(\frac{\pi}{L} \right) \left[\frac{Z_{in}}{h \sin\left(\frac{\pi x_0}{L}\right)} \right]$$

Calculation of Probe Current (cont.)

At resonance,

$$Z_{\text{in}} = R_{\text{edge}} \sin^2\left(\frac{\pi x_0}{L}\right) \quad (\text{The origin is at the center of the patch here.})$$

Hence, we have:

$$\frac{A_{10}^J}{I_0} = -\frac{1}{j\omega\mu} \left(\frac{\pi}{L}\right) \left[\frac{R_{\text{edge}}}{h}\right] \sin\left(\frac{\pi x_0}{L}\right)$$

Calculation of Probe Current (cont.)

We can also write this as

$$\frac{I_{\text{patch}}}{I_0} = \frac{WA_{10}^J}{I_0} = -\frac{\pi}{j\omega\mu} \left(\frac{W}{L}\right) \left[\frac{R_{\text{edge}}}{h}\right] \sin\left(\frac{\pi x_0}{L}\right) = j \left(\frac{\pi}{\mu_r k_0 \eta_0}\right) \left(\frac{W}{L}\right) \left[\frac{R_{\text{edge}}}{h}\right] \sin\left(\frac{\pi x_0}{L}\right)$$

I_{patch} is the total current (amps) flowing across the center of the patch.

We then have

$$\frac{I_{\text{patch}}}{I_0} = j \left(\frac{\pi}{\mu_r \eta_0}\right) \left(\frac{1}{k_0 h}\right) \left(\frac{W}{L}\right) R_{\text{edge}} \sin\left(\frac{\pi x_0}{L}\right)$$

Calculation of Probe Current (cont.)

Final result:

$$\frac{I_{\text{patch}}}{I_0} = j\pi \frac{R_{\text{edge}}}{\mu_r \eta_0} \left(\frac{1}{k_0 h} \right) \left(\frac{W}{L} \right) \sin \left(\frac{\pi x_0}{L} \right)$$

Note: For a thin substrate, the patch current is much larger than the probe current.

For a fixed patch current:

$$I_0 \propto k_0 h \quad \Rightarrow \quad I_0 h \propto (k_0 h)^2 \quad (\text{The term } I_0 h \text{ is a measure of how strong the probe radiates.)}$$

The probe radiation gets large quickly as the substrate gets thicker!

Summary

$$E_{\theta}^{\text{FF}}(r, \theta) = (I_0 h) \left(\frac{-1}{\epsilon_r} \right) E_0 e^{j(k_x x_0 + k_y y_0)} (1 - \Gamma^{\text{TM}}) \text{tanc}(k_0 h N_1(\theta)) \sin \theta$$

$$\frac{A_{10}^J}{I_0} = -\frac{1}{j\omega\mu} \left(\frac{\pi}{L} \right) \left[\frac{Z_{\text{in}}}{h \sin\left(\frac{\pi x_0}{L}\right)} \right]$$

Assumption: $J_{sx}(x, y) = A_{10}^J \cos\left(\frac{\pi x}{L}\right)$